

**SLOVENSKI STANDARD**  
**SIST EN 60249-2-13:1995/A1:1997**  
**01-avgust-1997**

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**Base materials for printed circuits - Part 2: Specifications - Specification No.13:  
Flexible copper-clad polyimide film, general purpose grade (IEC 249-2-  
13:1987/A1:1993) - Amendment A1**

Base materials for printed circuits -- Part 2: Specifications -- Specification No. 13:  
Flexible copper-clad laminated polyimide film, general purpose grade

Basismaterialien für gedruckte Schaltungen -- Teil 2: Einzelbestimmungen --  
Einzelbestimmung Nr. 13: Flexible kupferkaschierte Polyimidfolie für allgemeine  
Anwendungszwecke

SIST EN 60249-2-13:1995/A1:1997  
Matériaux de base pour circuits imprimés -- Partie 2: Spécifications -- Spécification n° 13:  
Film flexible de polyimide recouvert de cuivre, de qualité courante

**Ta slovenski standard je istoveten z: EN 60249-2-13:1994/A1:1994**

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**ICS:**

31.180      Tiskana vezja (TIV) in tiskane Printed circuits and boards  
                  plošče

**SIST EN 60249-2-13:1995/A1:1997**      en

**iTeh STANDARD PREVIEW  
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[SIST EN 60249-2-13:1995/A1:1997](#)

<https://standards.iteh.ai/catalog/standards/sist/5a107e05-fada-42e8-900b-65e795947004/sist-en-60249-2-13-1995-a1-1997>

UDC 621.3.049.75-036.7

Descriptors: Printed circuit, composite materials, polyimide, copper

## Amendment A1 to the English version of EN 60249-2-13

Base materials for printed circuits  
 Part 2: Specifications  
 Specification No. 13: Flexible copper-clad  
 polyimide film, general purpose grade  
 (IEC 249-2-13:1987/A1:1993)

Matériaux de base pour circuits  
 imprimés  
 Partie 2: Spécifications  
 Spécification n° 13: Film  
 flexible de polyimide recouvert  
 de cuivre, de qualité courante  
 (CEI 249-2-13:1987/A1:1993)

Basismaterialien für gedruckte  
 Schaltungen  
 Teil 2: Einzelbestimmungen  
 Einzelbestimmung Nr. 13:  
 Flexible kupferkaschierte  
 Polyimidfolie für allgemeine  
 Anwendungszwecke  
 (IEC 249-2-13:1987/A1:1993)

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This amendment A1 modifies the European Standard EN 60249-2-13:1994. It was approved by CENELEC on 1994-01-08. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this amendment the status of a ~~NATIONAL standard~~<sup>SIST EN 60249-2-13:1995/A1:1997</sup> without any alteration.

<https://standards.iteh.ai/catalog/standards/sist/5a107e05-fada-42e8-900b>

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

This amendment exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Denmark, Finland, France, Germany, Greece, Iceland, Ireland, Italy, Luxembourg, Netherlands, Norway, Portugal, Spain, Sweden, Switzerland and United Kingdom.

CENELEC

European Committee for Electrotechnical Standardization  
 Comité Européen de Normalisation Electrotechnique  
 Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B-1050 Brussels

FOREWORD

At the request of the 76th Technical Board of CENELEC, amendment 1:1993 to the International Standard IEC 249-2-13:1987 was submitted to the CENELEC members for formal vote.

The text of the International Standard was approved by CENELEC as amendment A1 to EN 60249-2-13 on 8 January 1994.

The following dates were fixed:

- latest date of publication of an identical national standard (dop) 1995-03-15
- latest date of withdrawal of conflicting national standards (dow) 1995-03-15

ENDORSEMENT NOTICE

The text of amendment 1:1993 to the International Standard IEC 249-2-13:1987 was approved by CENELEC as an amendment to the European Standard without any modification.

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[SIST EN 60249-2-13:1995/A1:1997](https://standards.iteh.ai/catalog/standards/sist/5a107e05-fada-42e8-900b-65e795947004/sist-en-60249-2-13-1995-a1-1997)  
<https://standards.iteh.ai/catalog/standards/sist/5a107e05-fada-42e8-900b-65e795947004/sist-en-60249-2-13-1995-a1-1997>

NORME  
INTERNATIONALE  
INTERNATIONAL  
STANDARD

CEI  
IEC  
249-2-13

1987

AMENDEMENT 1  
AMENDMENT 1

1993-05

Amendement 1

Matériaux de base pour circuits imprimés

iTeh STANDARD PREVIEW  
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Partie 2: Spécifications  
Spécification n° 13: Film flexible de polyimide  
recouvert de cuivre, de qualité courante

[SIST EN 60249-2-13:1995/A1:1997](#)

<https://standards.iteh.ai/catalog/standard/sist/5a107e05-fada-42e8-900b-65e795947004/sist-en-60249-2-13-1995-a1-1997>

Base materials for printed circuits

Part 2: Specifications

Specification No. 13: Flexible copper-clad  
polyimide film, general purpose grade

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Commission Electrotechnique Internationale  
International Electrotechnical Commission  
Международная Электротехническая Комиссия

CODE PRIX  
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## FOREWORD

This amendment has been prepared by IEC technical committee No. 52: Printed circuits.

The text of this amendment is based on the following documents:

DIS	Reports on Voting
52(CO)378	52(CO)387
52(CO)380	52(CO)389
52(CO)391	52(CO)395

Full information on the voting for the approval of this amendment can be found in the reports on voting indicated in the above table.

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### 4 Electrical properties, table III

[SIST EN 60249-2-13:1995/A1:1997](#)

Replace the present property designation by:

[65e795947004/sist-en-60249-2-13-1995-a1-1997](#)

Surface resistance after damp heat while in the humidity chamber (optional)

Surface resistance after damp heat and recovery

Volume resistivity after damp heat while in the humidity chamber (optional)

Volume resistivity after damp heat and recovery

Replace table VI as follows:

Property	Test method (Subclause of IEC 249-1)	Requirements		
		Thickness of the copper foil		
		18 µm*	35 µm*	70 µm*
Peel strength as received	3.6	Not less than 0,6 N/mm (3,4 lbf/in)	Not less than 0,8 N/mm (4,6 lbf/in)	Not less than 0,9 N/mm (5,1 lbf/in)
Peel strength after dry heat for 30 min at 125 °C and heat shock for 10 s	3.6.3	Not less than 0,6 N/mm (3,4 lbf/in)	Not less than 0,8 N/mm (4,6 lbf/in)	Not less than 0,9 N/mm (5,1 lbf/in)
		No blistering nor delamination		
Peel strength after dry heat for 30 min at 200 °C (optional)	3.6.3	Not less than 0,5 N/mm (2,9 lbf/in)	Not less than 0,7 N/mm (4,0 lbf/in)	Not less than 0,8 N/mm (4,6 lbf/in)
		No blistering nor delamination		
Retention of peel strength after immersion in solvent	3.6.6 but duration 3 min instead of 10 min	Not less than 75 % of the previous values. No blistering nor delamination, tackiness or colour change		
Retention of peel strength after simulated plating (optional)	3.6.5 but current density 50 A/m <sup>2</sup> instead of 215 A/m <sup>2</sup>	Not less than 75 % of the previous values. No blistering nor delamination, tackiness or colour change		

SIST EN 60249-2-13:1995/A1:1997

- \* 18 µm (152 g/m<sup>2</sup>, 0,5 oz/ft<sup>2</sup>); 35 µm (305 g/m<sup>2</sup>, 1 oz/ft<sup>2</sup>);  
70 µm (610 g/m<sup>2</sup>, 2 oz/ft<sup>2</sup>). <https://standards.itech.ai/catalog/standard/list/5a107e05-fada-42e8-900b-65e795947004/sist-en-60249-2-13-1995-a1-1997>

## 5.6 Solderability

Delete the title and text of 5.6.